

Notice of References Cited	Application/Control No. 09/698,168	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner DiLinh Nguyen	Art Unit 2814	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,313,532 B1	11-2001	Shimoishizaka et al.	257/734
	B	US-6,323,439 B1	11-2001	Kambe et al.	174/262
	C	US-6,425,516 B1	07-2002	Iwatsu et al.	228/180.22
	D	US-6,130,484	10-2000	Kameda et al.	257/786
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63-200415	08-1988	JP	Yokota et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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